



INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
2038-285

U.S. PATENT
APPLICATION NO.
10/067,334

APPLICANT
Toshifumi OTSUBO

FILING DATE
February 7, 2002

GROUP 3761

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>mk</i>	5,382,246	1/1995	Kawano			duplicate
	5,792,130	8/1998	Widlund et al			
	6,152,908	11/2000	Widlund et al			duplicate

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	<i>Michelle Tidwell</i>
DATE CONSIDERED	<i>9/27/05</i>

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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3761

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
MCC	1057463	12-2000	Europe			✓	
	1034760	09-2000	Europe			✓	
	0990434	04-2000	Europe			✓	
	0990433	04-2000	Europe			✓	
	0966940	12-1999	Europe			✓	
MCC	0763353	03-1997	Europe			✓	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

Michek Kidwell

DATE CONSIDERED

ED 9 | 27 | 05

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